Notice of References Cited 10/519,477 HAP

10/510 477	Reexamination HAMADA ET AL.	nt Under
Examiner	Art Unit	
AMY HSU	2622	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. PATERT DOGGMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,724,579 A	03-1998	Suzuki, Takeshi	707/104.1
*	В	US-6,313,877 B1	11-2001	Anderson, Eric C.	348/333.05
*	С	US-6,445,412 B1	09-2002	Shiohara, Ryuichi	348/333.05
*	D	US-2003/0122940 A1	07-2003	Myojo, Toshihiko	348/231.2
*	Е	US-6,734,909 B1	05-2004	Terane et al.	348/333.05
*	F	US-7,038,724 B2	05-2006	Satoh et al.	348/333.05
*	G	US-7,176,964 B1	02-2007	Sogabe et al.	348/220.1
*	Н	US-2007/0109428 A1	05-2007	Suzuki et al.	348/231.99
*	Т	US-7,227,576 B2	06-2007	Umeyama, Kazuya	348/333.11
*	J	US-7,046,290	05-2006	Nozaki, Hirotake	348/350
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

_	NON-ATENI DOCUMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	×					

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.